**ON Semiconductor®** 



#### Sept 2017

# FCA47N60F N-Channel SuperFET<sup>®</sup> FRFET<sup>®</sup> MOSFET

600 V, 47 A, 73 m $\Omega$ 

### Features

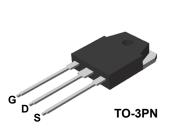
- 650 V @ T<sub>J</sub> = 150 °C
- Typ. R<sub>DS(on)</sub> = 62 mΩ
- Fast Recovery Time (Typ. T<sub>rr</sub> = 240 ns)
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 210 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 420 pF)
- 100% Avalanche Tested
- RoHS Compliant

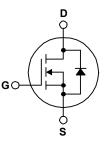
## Applications

- Solar Inverter
- AC-DC Power Supply

# Description

SuperFET<sup>®</sup> MOSFET is ON Semiconductor's first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low onresistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. Super-FET FRFET<sup>®</sup> MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.





#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter			FCA47N60F	Unit	
V <sub>DSS</sub>	Drain-Source Voltage			600	V	
ID	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		47 29.7	A A	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	141	A	
V <sub>GSS</sub>	Gate-Source voltage	ge		$\pm 30$	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	1800	mJ	
I <sub>AR</sub>	Avalanche Current		(Note 1)	47	A	
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	41.7	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	50	V/ns	
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate Above 25°C		417 3.33	W W/°C	
T <sub>J,</sub> T <sub>STG</sub>	Operating and Sto	rage Temperature Range		-55 to +150	°C	
Τ <sub>L</sub>	Maximum Lead Te 1/8" from Case for	mperature for Soldering, 5 Seconds		300	°C	

#### **Thermal Characteristics**

Symbol	Parameter	FCA47N60F	Unit	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case, Max.	0.3	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient, Max.	41.7	°C/W	

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Part Number Top Mark F		Package	Package Packing Method Reel Size		Та	pe Width	Qu	antity		
FCA4			TO-3PN	Tube	N/A		N/A	30	30 units	
Electric	al Chara	acteristics T <sub>C</sub> = 25°C	unless otherwise	noted						
Symbol	I Parameter			Conditions			Тур.	Max.	Unit	
Off Charac	teristics									
BV <sub>DSS</sub>	V <sub>DSS</sub> Drain-Source Breakdown Voltage		$V_{GS} = 0$	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA, T <sub>J</sub> = 25°C					V	
			$V_{GS} = 0$	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA, T <sub>J</sub> = 150°C			650		V	
ΔΒV <sub>DSS</sub> / ΔΤ <sub>J</sub>	Breakdowr Coefficient	N Voltage Temperature	I <sub>D</sub> = 250	$I_D$ = 250 µA, Referenced to 25°C			0.6		V/°C	
BV <sub>DS</sub>	Drain to So Voltage	ource Avalanche Breakdow	n V <sub>GS</sub> = 0	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 47 A			700		V	
I <sub>DSS</sub>	Zero Gate	Voltage Drain Current		$V_{DS}$ = 600 V, $V_{GS}$ = 0 V, $V_{DS}$ = 480 V, $T_{C}$ = 125°C				10 100	μΑ μΑ	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward $V_{GS}$ = 3			: 30 V, V <sub>DS</sub> = 0 V				100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse			$V_{GS}$ = -30 V, $V_{DS}$ = 0 V				-100	nA	
On Charac	teristics									
V <sub>GS(th)</sub>	Gate Three	shold Voltage	$V_{DS} = V$	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A				5.0	V	
R <sub>DS(on)</sub>	Static Drain On-Resista		V <sub>GS</sub> = 1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 23.5 A			0.062	0.073	Ω	
9 <sub>FS</sub>	Forward Transconductance		V <sub>DS</sub> = 2	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 23.5 A			40		S	
Dynamic C	haracterist	ics								
C <sub>iss</sub>	Input Capa	icitance		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz			5900	8000	pF	
C <sub>oss</sub>	Output Cap	pacitance	t = 1 MH				3200	4200	pF	
C <sub>rss</sub>	Reverse T	ransfer Capacitance					250		pF	
C <sub>oss</sub>	Output Cap	pacitance	V <sub>DS</sub> = 4	$V_{DS}$ = 480 V, $V_{GS}$ = 0 V, f = 1 MHz			160		pF	
Coss(eff.)	Effective C	output Capacitance	$V_{DS} = 0$	$V_{DS}$ = 0 V to 400 V, $V_{GS}$ = 0 V			420		pF	
Switching	Characteris	tics								
t <sub>d(on)</sub>	Turn-On D	elay Time		$V_{DD}$ = 300 V, I <sub>D</sub> = 47 A, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 25 Ω			185	430	ns	
t <sub>r</sub>	Turn-On R	ise Time	V <sub>GS</sub> = 1				210	450	ns	
t <sub>d(off)</sub>	Turn-Off D	elay Time					520	1100	ns	
t <sub>f</sub>	Turn-Off Fa	all Time			(Note 4)		75	160	ns	
Qg	Total Gate	Charge		$V_{DS}$ = 480 V, I <sub>D</sub> = 47 A, V <sub>GS</sub> = 10 V			210	270	nC	
Q <sub>gs</sub>	Gate-Sour	ce Charge	V <sub>GS</sub> = 1				38		nC	
Q <sub>gd</sub>	Gate-Drain	1 Charge			(Note 4)		110		nC	
Drain-Sou	rce Diode C	haracteristics and Maxim	um Ratings	; ;						
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current			rd Current				47	А	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Fo			prward Current				141	А	
V <sub>SD</sub>	Drain-Sour	ce Diode Forward Voltage	$V_{GS} = 0$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 47 A				1.4	V	
t <sub>rr</sub>	Reverse R	ecovery Time		$V_{GS} = 0 V, I_S = 47 A,$ $dI_F/dt = 100 A/\mu s$			240		ns	
Q <sub>rr</sub>	Reverse R	ecovery Charge	dl <sub>F</sub> /dt =				2.04		μC	

#### Notes:

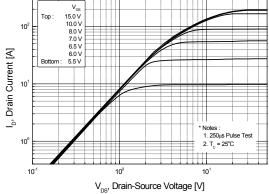
1. Repetitive rating: pulse-width limited by maximum junction temperature.

2. I<sub>AS</sub> = 18 A, V<sub>DD</sub> = 50 V, R<sub>G</sub> = 25  $\Omega$ , starting T<sub>J</sub> = 25°C.

3. I\_{SD} \leq 47 A, di/dt  $\leq$  1200 A/µs, V\_{DD}  $\leq$  BV\_{DSS}, starting T\_J = 25°C.

4. Essentially independent of operating temperature typical characteristics.

# Typical Performance Characteristics Figure 1. On-Region Characteristics Figure 1. On-Region Characteristics





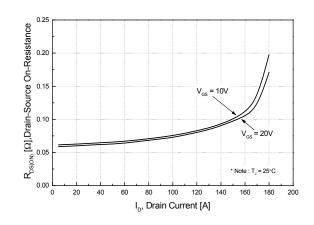
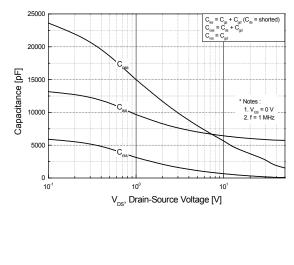
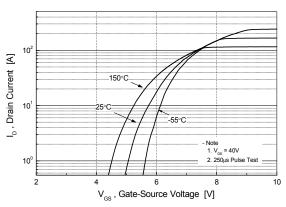


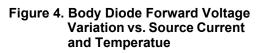
Figure 5. Capacitance Characteristics

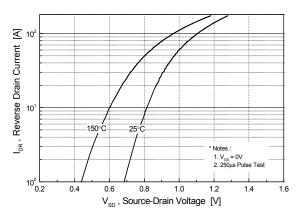


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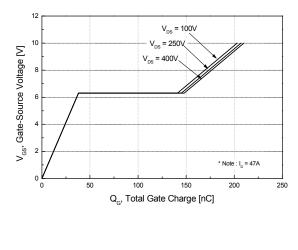
#### Figure 2. Transfer Characteristics

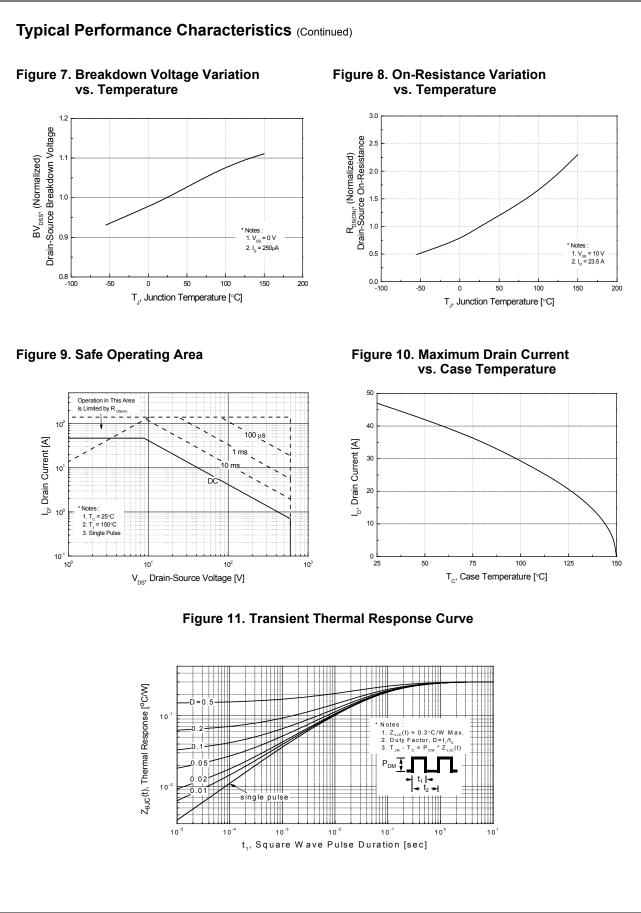






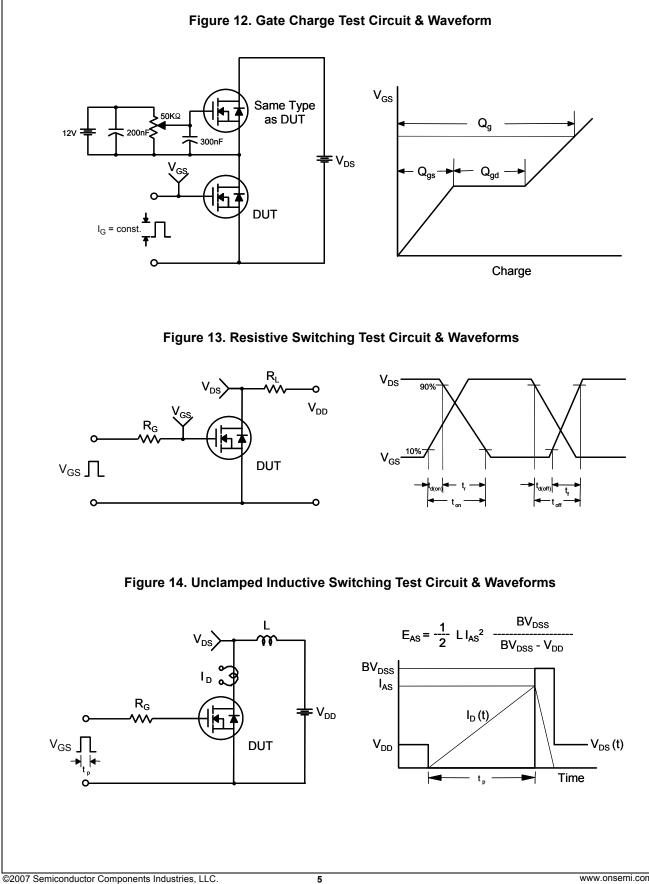


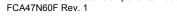




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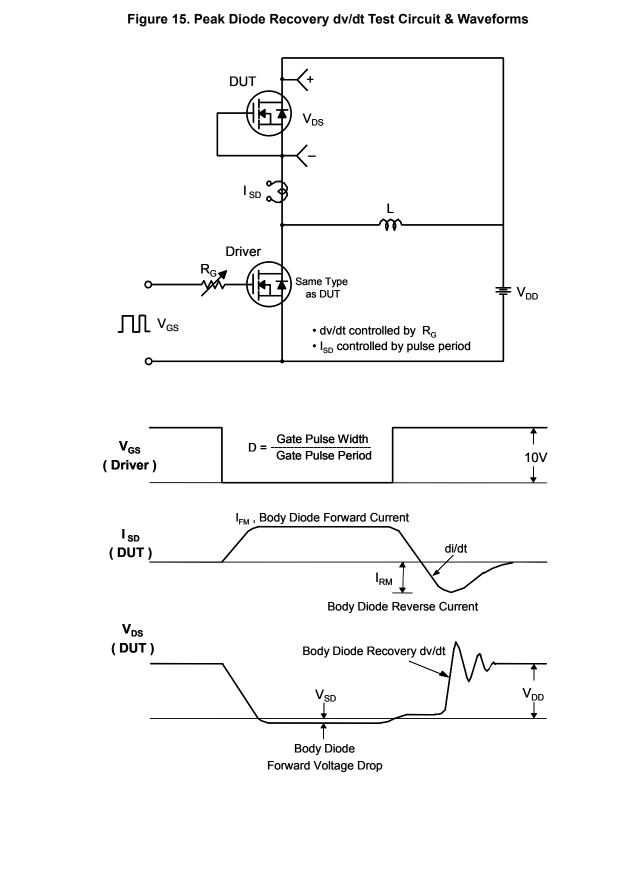
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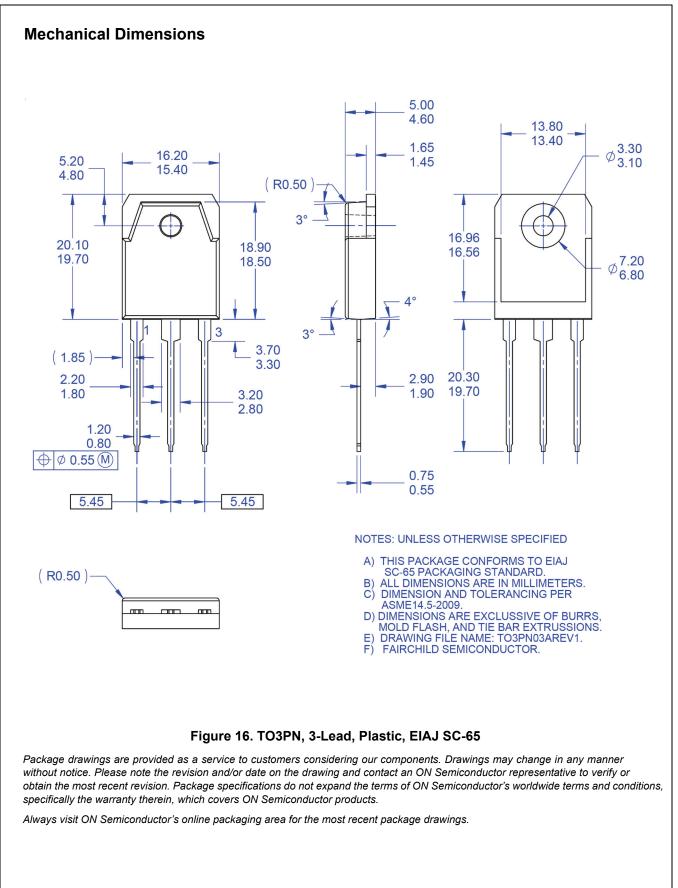




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